


<b>Search Notes</b>  	<b>Application/Control No.</b>  10514427	<b>Applicant(s)/Patent Under Reexamination</b>  CAI ET AL.
	<b>Examiner</b>  O'Dell, Ph.D., David K	<b>Art Unit</b>  1609

SEARCHED			
Class	Subclass	Date	Examiner
548	430	12/5/2008	dko
514	411	12/5/2008	dko

SEARCH NOTES		
Search Notes	Date	Examiner
STN Structure (see attached), EAST, PALM inventor name	5/2/07	D.O'Dell

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
514	411	12/5/2008	dko

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